

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination 10/567,484 IWASHITA ET AL.	
		Examiner	Art Unit YEWEBDAR T. TADESSE 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0001868	01-2005	Matsuba et al.	347/017
*	B	US-6,120,122	09-2000	Takemoto et al.	347/13
	C	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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